

TO. : MINDA




NO. : M201124



APPROVAL SHEET

MULTILAYER CERAMIC CAPACITOR
Commercial Grade
(High Voltage Type (100V~3000V))
(IEC-60384 Qualified)

Approved by customer : (signing or stamping here)

| SAMWHA CAPACITOR CO., LTD. | | |
|---|---|--|
| Written by | Checked by | Approved by |
|  |  |  |

2020. 11. 24.



SAMWHA CAPACITOR CO., LTD.

Address : 124, BUK-RI, NAMSA-MYUN YOUNGIN-SI, KYUNGKI-DO, KOREA

Contact : TEL 82-31-332-6441 , FAX 82-31-332-7661

Home page : www.samwha.com

< SPEC SUMMARY >

| SAMWHA Part no. | | CS3225X7R225K101NRK | |
|-----------------------|-----------------|---------------------|---|
| Type | | High voltage | |
| Item | Specification | Unit | Test methods and Conditions(Capacitance,IR) |
| Capacitance | 2.2 | μF | Testing Frequency : 1 \pm 0.2kHz Testing Voltage : 1 \pm 0.2Vrms |
| Capacitance Tolerance | ± 10 | % | |
| Dissipation Factor | Max. 5 | % | |
| Insulation Resistance | More than 45.4 | $\text{M}\Omega$ | Applied the rated voltage for 2 minutes of charging. |
| Chip Size | 3.20 \pm 0.40 | L (mm) | *Capacitance Tolerance Code --- page 1/9 *Chip size ----- page 2/9 *Characteristics & Test Method ---- page 3/9~6/9 |
| | 2.50 \pm 0.25 | W (mm) | |
| | 2.00 \pm 0.25 | T (mm) | |

| | | | |
|------------------------------|--|------|--------------|
| Enactment : March 27,1996 | STANDARD | NO | SW - M - 04B |
| | MULTILAYER CERAMIC CAPACITOR Commercial Grade | Page | 1 / 9 |

1. General Article

Application Range

These specifications refer to the "Multilayer Ceramic Capacitors "mainly used to the computer equipment, communication equipment.

***Caution : Industrial equipment / For the high reliability equipment / LED equipment / Etc.
Please contact sales representatives or product engineers before using the products.
(For details, please refer Page 9)**

2. General Code

(1) Type Designation

| | | | | | | | | |
|-----------|-------------|------------|------------|----------|------------|----------|----------|----------|
| <u>CS</u> | <u>3225</u> | <u>X7R</u> | <u>225</u> | <u>K</u> | <u>101</u> | <u>N</u> | <u>R</u> | <u>K</u> |
| (1) | (2) | (3) | (4) | (5) | (6) | (7) | (8) | (9) |

1) Multilayer Ceramic Capacitor (Commercial Grade)

2) Size Code :

This is expressed in tens of a millimeter.

The first two digits are the length, The last two digits are width.

3) Temperature Coefficient Code

| Classification | Code | Temperature Range | Capacitance Tolerance |
|----------------|------|-------------------|-----------------------|
| Class I | C0G | -55 to +125°C | ±30 ppm/°C |
| Class II | X5R | -55 to +85°C | ±15% |
| | X7R | -55 to +125°C | ±15% |
| | Y5V | -30 to +85°C | +22% ~ -82% |

4) Capacitance Code(Pico farads) :

The nominal Capacitance Value in pF is expressed by three digit numbers.

The first two digits represents significant figures and the last digit denotes the number of zero

ex) 104 = 100000 pF

R denotes decimal

8R2 = 8.2 pF

5) Capacitance Tolerance Code

| Code | Tolerance |
|------|-----------|
| B | ± 0.1 pF |
| C | ± 0.25 pF |
| D | ± 0.5 pF |
| F | ± 1.0 % |
| G | ± 2.0 % |
| J | ± 5 % |
| K | ± 10 % |

| Code | Tolerance |
|------|--------------|
| M | ± 20 % |
| P | + 100, - 0% |
| Z | + 80, - 20% |
| H | + 0.25/-0 pF |
| I | + 0/-0.25 pF |
| U | + 5/-0 % |
| V | + 0/-5 % |

6) Voltage Code

| | | | | | | | | | | | | | | |
|------|------------|-----------|-----------|-----------|-----------|-----------|------------|------------|------------|------------|------------|-----------|-----------|-----------|
| code | 6R3 | 100 | 160 | 250 | 350 | 500 | 101 | 201 | 251 | 501 | 631 | 102 | 202 | 302 |
| Vol. | DC 6.3V | DC 10V | DC 16V | DC 25V | DC 35V | DC 50V | DC 100V | DC 200V | DC 250V | DC 500V | DC 630V | DC 1KV | DC 2KV | DC 3KV |

7) Termination Code

ex) N : Ni-Sn (Nickel-Tin Plate)

A : Ag/Ni-Sn (Ag Epoxy/Nickel-Tin Plate) -> **Soft Termination Type**

8) Packing Code

ex) R : 7" Reel Type

L : 13" Reel Type

B : Bulk Type

9) Thickness option

| Thickness(mm) | | Code | Thickness(mm) | | Code |
|---------------|--------|-------|---------------|--------|------|
| t | Tol(±) | | t | Tol(±) | |
| 0.30 | 0.03 | Blank | 1.30 | 0.20 | E |
| 0.50 | 0.05 | Blank | 1.35 | 0.20 | H |
| 0.60 | 0.10 | A | 1.60 | 0.20 | I |
| 0.80 | 0.10 | B | 1.80 | 0.20 | J |
| 0.85 | 0.15 | B | 2.00 | 0.25 | K |
| 1.00 | 0.15 | E | 2.50 | 0.25 | L |
| 1.10 | 0.15 | E | 2.80 | 0.30 | M |
| 1.15 | 0.15 | E | 3.20 | 0.30 | N |
| 1.25 | 0.15 | E | 5.00 | 0.40 | O |

3. Temperature Characteristics

See Page 3/9 (No.7)

4. Constructions and Dimensions

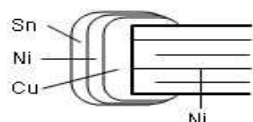
(1) Dimensions



(Unit : mm)

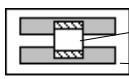
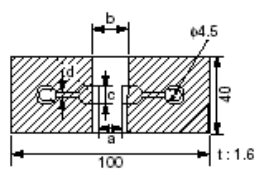
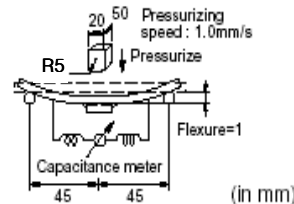
| Code | Dimension | | | | | |
|------|-----------|--------|-------|--------|---------|--------|
| | Length | | Width | | T1(min) | G(min) |
| | L | Tol(±) | W | Tol(±) | | |
| 0603 | 0.60 | 0.03 | 0.30 | 0.03 | 0.05 | 0.15 |
| 1005 | 1.00 | 0.05 | 0.50 | 0.05 | 0.05 | 0.30 |
| 1608 | 1.60 | 0.15 | 0.80 | 0.10 | 0.10 | 0.50 |
| 2012 | 2.00 | 0.20 | 1.25 | 0.15 | 0.10 | 0.65 |
| 3216 | 3.20 | 0.30 | 1.60 | 0.20 | 0.15 | 1.00 |
| 3225 | 3.20 | 0.40 | 2.50 | 0.25 | 0.15 | 1.05 |
| 4520 | 4.50 | 0.40 | 2.00 | 0.25 | 0.20 | 1.50 |
| 4532 | 4.50 | 0.40 | 3.20 | 0.30 | 0.20 | 1.50 |
| 5750 | 5.70 | 0.50 | 5.00 | 0.40 | 0.30 | 1.85 |

(2) Construction of Termination



Specifications and Test Methods (High voltage type)

| No. | Item | Specification | | Test Methods and Conditions | | | | | | | | | | | | | | | | |
|----------------|---|---|---|---|---|-------------------|-----------------|---------------------|-----|--------------------|---------------------------|-----------|---------------------------------|---------------------------|----------|-------------|---------------------------|-------|---------------------------|----------------|
| | | Class I | Class II | | | | | | | | | | | | | | | | | |
| 1 | Operating Temperature Range | COG :-55 to+125℃ | X7R : -55 to +125℃ | | | | | | | | | | | | | | | | | |
| 2 | Dimensions | Within the specified dimension | | Using calipers | | | | | | | | | | | | | | | | |
| 3 | Voltage proof | No defects or abnormalities | | <p>No failure should be observed when voltage in table is applied between the terminations, provided the charge/discharge current is less than 50mA.</p> <table border="1"> <thead> <tr> <th>Cap.</th> <th>Rated voltage</th> <th>Test voltage</th> <th>Time</th> </tr> </thead> <tbody> <tr> <td rowspan="3">COG</td> <td>DC100V~630V</td> <td>150% of the rated voltage</td> <td rowspan="6">1to5 sec.</td> </tr> <tr> <td>DC1kV, DC2kV DC3kV, DC3.15kV</td> <td>120% of the rated voltage</td> </tr> <tr> <td rowspan="3">X7R</td> <td>DC100V~630V</td> <td>150% of the rated voltage</td> </tr> <tr> <td>DC1kV</td> <td rowspan="2">120% of the rated voltage</td> </tr> <tr> <td>DC2kV DC3kV</td> </tr> </tbody> </table> | Cap. | Rated voltage | Test voltage | Time | COG | DC100V~630V | 150% of the rated voltage | 1to5 sec. | DC1kV, DC2kV DC3kV, DC3.15kV | 120% of the rated voltage | X7R | DC100V~630V | 150% of the rated voltage | DC1kV | 120% of the rated voltage | DC2kV DC3kV |
| Cap. | Rated voltage | Test voltage | Time | | | | | | | | | | | | | | | | | |
| COG | DC100V~630V | 150% of the rated voltage | 1to5 sec. | | | | | | | | | | | | | | | | | |
| | DC1kV, DC2kV DC3kV, DC3.15kV | 120% of the rated voltage | | | | | | | | | | | | | | | | | | |
| | X7R | DC100V~630V | | 150% of the rated voltage | | | | | | | | | | | | | | | | |
| DC1kV | | 120% of the rated voltage | | | | | | | | | | | | | | | | | | |
| DC2kV DC3kV | | | | | | | | | | | | | | | | | | | | |
| 4 | Insulation Resistance | More than 10,000 MΩ | | -DC100V~1KV :C≥0.01μF:More than 100MΩ,μF :C<0.01μF:More than 10,000MΩ -DC2~3KV:More than6,000 MΩ | Rated voltage <DC500V : Applied the rated voltage for 2 minutes of charging. Rated voltage ≥DC500V : The insulation resistance should be measured with DC500±50V and within 2 minutes of charging. | | | | | | | | | | | | | | | |
| 5 | Capacitance | within the specified tolerance | | <table border="1"> <thead> <tr> <th>Cap</th> <th>Testing frequency</th> <th>Testing Voltage</th> <th>Measure temperature</th> </tr> </thead> <tbody> <tr> <td rowspan="2">COG</td> <td>1±0.2MHz(C<1000pF)</td> <td rowspan="3">AC 1±0.2Vrms</td> <td rowspan="3">25℃</td> </tr> <tr> <td>1±0.1kHz(C≥1000pF)</td> </tr> <tr> <td>X7R</td> <td>1±0.2kHz</td> </tr> </tbody> </table> | Cap | Testing frequency | Testing Voltage | Measure temperature | COG | 1±0.2MHz(C<1000pF) | AC 1±0.2Vrms | 25℃ | 1±0.1kHz(C≥1000pF) | X7R | 1±0.2kHz | | | | | |
| Cap | Testing frequency | Testing Voltage | Measure temperature | | | | | | | | | | | | | | | | | |
| COG | 1±0.2MHz(C<1000pF) | AC 1±0.2Vrms | 25℃ | | | | | | | | | | | | | | | | | |
| | 1±0.1kHz(C≥1000pF) | | | | | | | | | | | | | | | | | | | |
| X7R | 1±0.2kHz | | | | | | | | | | | | | | | | | | | |
| 6 | Dissipation Factor | COG Char. : 30pFmin : Q≥1,000(DF≤0.1%) 30pFmax : Q≥400+20C (DF≤1/ (400+20C)) | 5% max | <ul style="list-style-type: none"> Initial measurement Perform the initial measurement according to Note1 for Class II Measurement after test Take it out and set it for 24±2 hours (Class I) or 24±2 hours (Class II) then measure | | | | | | | | | | | | | | | | |
| 7 | Temperature characteristic of capacitance | Temp. Coefficient COG char. : 0±30ppm/℃ (Temp. Range : -55to+125℃) | Cap. Change within ±15% (Temp. Range : -55 to +125℃) | COG : The temperature coefficient is determined using the capacitance measured in step 3 as a reference. When cycling the temperature sequentially from step 1 through 5 the capacitance should be within the specified tolerance for the temperature coefficient. <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(℃)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>25±2</td> </tr> <tr> <td>2</td> <td>-55±3</td> </tr> <tr> <td>3</td> <td>25±2</td> </tr> <tr> <td>4</td> <td>125±3 (for COG)</td> </tr> <tr> <td>5</td> <td>25±2</td> </tr> </tbody> </table> <p>X7R : The range of capacitance change compared with the 25℃value should be within the specified range. -Pretreatment Perform a heat treatment at 150 -10, +0℃ for 60±5min. and then let sit for 24±2hrs.(Class I), 24±2hrs.(Class II) at room Temperature</p> | Step | Temperature(℃) | 1 | 25±2 | 2 | -55±3 | 3 | 25±2 | 4 | 125±3 (for COG) | 5 | 25±2 | | | | |
| Step | Temperature(℃) | | | | | | | | | | | | | | | | | | | |
| 1 | 25±2 | | | | | | | | | | | | | | | | | | | |
| 2 | -55±3 | | | | | | | | | | | | | | | | | | | |
| 3 | 25±2 | | | | | | | | | | | | | | | | | | | |
| 4 | 125±3 (for COG) | | | | | | | | | | | | | | | | | | | |
| 5 | 25±2 | | | | | | | | | | | | | | | | | | | |

| No. | Item | Specification | | Test Methods and Conditions | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|----------|----------------------------------|---|---------------|--|----------|---------------|--|--|--|---|---|---|---|---------|-----|-----|-----|-----|----------|-----|-----|------|---------|-----|-----|-----|---------|-----|-----|-----|---------|-----|-----|-----|---------|-----|-----|-----|
| | | Class I | Class II | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 8 | Adhesive Strength of Termination | No removal of the terminations or other defect should occur | | <p>Solder the capacitor to the testing jig(glass epoxy board) shown in Fig. 1 using a eutectic solder. Then apply 10N force in the direction of the arrow. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.</p>  <p>10N(5N:Size 1.6×0.8mm only), 10±1s Speed : 1.0mm/s Glass Epoxy Board</p> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 9 | Appearance | No defects or abnormalities | | <p>The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2hrs. in each 3mutually perpendicular directions(total of 6hrs.)</p> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| | Capacitance | Within the specified tolerance | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| | Dissipation Factor(or Q) | <p>COG Char. : 30pFmin : $Q \geq 1,000(DF \leq 0.1\%)$ 30pFmax : $Q \geq 400+20C$ ($DF \leq 1/ (400+20C)$)</p> | 5% max | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 10 | Substrate bending test | No cracking defects should occur. | | <p>Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 2 using a eutectic solder. Then apply a force in the direction shown in Fig. 3. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.</p>  <table border="1" data-bbox="430 1523 917 1736"> <thead> <tr> <th rowspan="2">L×X (mm)</th> <th colspan="4">Dimension(mm)</th> </tr> <tr> <th>a</th> <th>b</th> <th>c</th> <th>d</th> </tr> </thead> <tbody> <tr> <td>1.6×0.8</td> <td>1.0</td> <td>3.0</td> <td>1.2</td> <td rowspan="6">1.0</td> </tr> <tr> <td>2.0×1.25</td> <td>1.2</td> <td>4.0</td> <td>1.65</td> </tr> <tr> <td>3.2×1.6</td> <td>2.2</td> <td>5.0</td> <td>2.0</td> </tr> <tr> <td>3.2×2.5</td> <td>2.2</td> <td>5.0</td> <td>2.9</td> </tr> <tr> <td>4.5×2.0</td> <td>3.5</td> <td>7.0</td> <td>2.4</td> </tr> <tr> <td>4.5×3.2</td> <td>3.5</td> <td>7.0</td> <td>3.7</td> </tr> </tbody> </table>  <p>*. Test condition - Bending limit : 1mm - Pressurizing speed : 1mm/sec - Holding time : 5±1sec</p> | L×X (mm) | Dimension(mm) | | | | a | b | c | d | 1.6×0.8 | 1.0 | 3.0 | 1.2 | 1.0 | 2.0×1.25 | 1.2 | 4.0 | 1.65 | 3.2×1.6 | 2.2 | 5.0 | 2.0 | 3.2×2.5 | 2.2 | 5.0 | 2.9 | 4.5×2.0 | 3.5 | 7.0 | 2.4 | 4.5×3.2 | 3.5 | 7.0 | 3.7 |
| | | L×X (mm) | Dimension(mm) | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| a | b | | c | d | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1.6×0.8 | 1.0 | 3.0 | 1.2 | 1.0 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 2.0×1.25 | 1.2 | 4.0 | 1.65 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 3.2×1.6 | 2.2 | 5.0 | 2.0 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 3.2×2.5 | 2.2 | 5.0 | 2.9 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 4.5×2.0 | 3.5 | 7.0 | 2.4 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 4.5×3.2 | 3.5 | 7.0 | 3.7 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 11 | Solderability | 95% of the terminations is to be soldered evenly and continuously. | | <p>Immerse the capacitor in a solution of ethanol and rosin(25% rosin in weight proportion). Immerse in eutectic solder solution for 2±0.5 sec. at 245±5°C. Immersing speed : 25±2.5mm/s</p> | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |

| No. | Item | Specification | | Test Methods and Conditions | | | | | | | | | | | | | | | |
|-----------------------------|-----------------------------------|---------------------------|--|--|-----------------------------|---------------|--------------|-----|-----------------------------------|---------------|--------------------------------|---------------------------|------------------------------|-------------|---------------------------|-------------|---------------------------|-------------|---------------------------|
| | | Class I | Class II | | | | | | | | | | | | | | | | |
| 12 | Resistance to Soldering Heat | Appearance | No defects which may affect performance | | | | | | | | | | | | | | | | |
| | | Capacitance change | within $\pm 2.5\%$ or $\pm 0.25\text{pF}$ (whichever is larger) | within $\pm 10\%$ | | | | | | | | | | | | | | | |
| | | Dissipation Factor (or Q) | COG Char. : 30pFmin : $Q \geq 1,000 (DF \leq 0.1\%)$ 30pFmax : $Q \geq 400+20C (DF \leq 1/ (400+20C))$ | 5% max | | | | | | | | | | | | | | | |
| | | I.R. | More than 10,000M Ω | -DC100V~1KV : $C \geq 0.01\mu\text{F}$: More than 100M $\Omega \cdot \mu\text{F}$: $C < 0.01\mu\text{F}$: More than 10,000M Ω -DC2~3KV: More than 1,000 M Ω | | | | | | | | | | | | | | | |
| | | | | Preheat the capacitor at 120 to 150°C* for 1 min. Immerse the capacitor in eutectic solder solution at 260 $\pm 5^\circ\text{C}$ for 10 ± 1 sec. -Immersing speed : 25 $\pm 2.5\text{mm/s}$ -Initial measurement Perform the initial measurement according to Note1 for Class II -Measurement after test Let sit at room Temperature for 24 ± 2 hrs.(Class I), 24 ± 2 hrs.(Class II) then measure. *Preheating for more than 3.2 $\times 2.5\text{mm}$ <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Step</th> <th>Temperature</th> <th>Time</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>100°C to 120°C</td> <td>1 min</td> </tr> <tr> <td>2</td> <td>170°C to 200°C</td> <td>1 min</td> </tr> </tbody> </table> | Step | Temperature | Time | 1 | 100°C to 120°C | 1 min | 2 | 170°C to 200°C | 1 min | | | | | | |
| Step | Temperature | Time | | | | | | | | | | | | | | | | | |
| 1 | 100°C to 120°C | 1 min | | | | | | | | | | | | | | | | | |
| 2 | 170°C to 200°C | 1 min | | | | | | | | | | | | | | | | | |
| 13 | Rapid change of temperature | Appearance | No defects which may affect performance | | | | | | | | | | | | | | | | |
| | | Capacitance Change | Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$ (whichever is larger) | within $\pm 15\%$ | | | | | | | | | | | | | | | |
| | | Dissipation Factor (or Q) | COG Char. : 30pFmin : $Q \geq 1,000 (DF \leq 0.1\%)$ 30pFmax : $Q \geq 400+20C (DF \leq 1/ (400+20C))$ | 5% max | | | | | | | | | | | | | | | |
| | | I.R. | More than 10,000M Ω | -DC100V~1KV : $C \geq 0.01\mu\text{F}$: More than 100M $\Omega \cdot \mu\text{F}$: $C < 0.01\mu\text{F}$: More than 10,000M Ω -DC2~3KV: More than 3,000M Ω | | | | | | | | | | | | | | | |
| | | | | Perform the 5 cycles according to the 4 heat treatments listed in the following table. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Step</th> <th>1</th> <th>2</th> <th>3</th> <th>4</th> </tr> </thead> <tbody> <tr> <td>Temp (°C)</td> <td>Min. operating temp. ± 3</td> <td>Room Temp</td> <td>Max. operating temp. ± 2</td> <td>Room Temp</td> </tr> <tr> <td>Time (min)</td> <td>30± 3</td> <td>2 to 3</td> <td>30± 3</td> <td>2 to 3</td> </tr> </tbody> </table> -Initial measurement Perform the initial measurement according to Note1 for Class II -Measurement after test Perform the final measurement according to Note2 | Step | 1 | 2 | 3 | 4 | Temp (°C) | Min. operating temp. ± 3 | Room Temp | Max. operating temp. ± 2 | Room Temp | Time (min) | 30 ± 3 | 2 to 3 | 30 ± 3 | 2 to 3 |
| Step | 1 | 2 | 3 | 4 | | | | | | | | | | | | | | | |
| Temp (°C) | Min. operating temp. ± 3 | Room Temp | Max. operating temp. ± 2 | Room Temp | | | | | | | | | | | | | | | |
| Time (min) | 30 ± 3 | 2 to 3 | 30 ± 3 | 2 to 3 | | | | | | | | | | | | | | | |
| 14 | Damp heat, steady state | Appearance | No defects which may affect performance | | | | | | | | | | | | | | | | |
| | | Capacitance Change | within $\pm 5\%$ or $\pm 0.5\text{pF}$ (Whichever is larger) | Within $\pm 15\%$ | | | | | | | | | | | | | | | |
| | | Dissipation Factor (or Q) | COG Char. : $C \geq 30\text{pF} : Q \geq 350$ $C < 30\text{pF} : Q \geq 275 + \frac{5}{2}C$ | 7.5% max | | | | | | | | | | | | | | | |
| | | I.R. | More than 1,000M Ω | -DC100V~1KV : $C \geq 0.01\mu\text{F}$: More than 10M $\Omega \cdot \mu\text{F}$: $C < 0.01\mu\text{F}$: More than 1,000M Ω -DC2~3KV: More than 1,000M Ω | | | | | | | | | | | | | | | |
| | | | | Let the capacitor sit at 40 $\pm 2^\circ\text{C}$ and relative humidity of 90 to 95% for 500+24/-0 hrs. -Initial measurement Perform the initial measurement according to Note1 for Class II -Measurement after test Perform the final measurement according to Note2 | | | | | | | | | | | | | | | |
| 15 | Endurance | Appearance | No defects which may affect performance | | | | | | | | | | | | | | | | |
| | | Capacitance Change | within $\pm 3\%$ or $\pm 0.3\text{pF}$ (Whichever is larger) | DC100V,630V: Within $\pm 15\%$ DC1KV: Within $\pm 20\%$ DC2~3KV: Within $\pm 20\%$ | | | | | | | | | | | | | | | |
| | | Dissipation (or Q) | COG Char. : $C \geq 30\text{pF} : Q \geq 350$ $C < 30\text{pF} : Q \geq 275 + \frac{5}{2}C$ | 7.5% max | | | | | | | | | | | | | | | |
| | | I.R. | More than 1,000M Ω | -DC100V~1KV : $C \geq 0.01\mu\text{F}$: More than 10M $\Omega \cdot \mu\text{F}$: $C < 0.01\mu\text{F}$: More than 1,000M Ω -DC2~3KV: More than 2,000M Ω | | | | | | | | | | | | | | | |
| | | | | Apply the voltage in following table for 1,000+48/-0hrs. at maximum operating temperature $\pm 3^\circ\text{C}$. The charge/discharge current is less than 50mA. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Operating temperature range</th> <th>Rated voltage</th> <th>Test voltage</th> </tr> </thead> <tbody> <tr> <td rowspan="2">COG</td> <td>Rated voltage $\geq \text{DC1KV}$</td> <td>Rated voltage</td> </tr> <tr> <td>Rated voltage $< \text{DC1KV}$</td> <td>120% of the rated voltage</td> </tr> <tr> <td rowspan="3">X7R</td> <td>DC100V~250V</td> <td>150% of the rated voltage</td> </tr> <tr> <td>DC500V~630V</td> <td>120% of the rated voltage</td> </tr> <tr> <td>DC1KV~DC3KV</td> <td>110% of the rated voltage</td> </tr> </tbody> </table> -Initial measurement Perform the initial measurement according to Note1 for Class II -Measurement after test Perform the final measurement according to Note2 | Operating temperature range | Rated voltage | Test voltage | COG | Rated voltage $\geq \text{DC1KV}$ | Rated voltage | Rated voltage $< \text{DC1KV}$ | 120% of the rated voltage | X7R | DC100V~250V | 150% of the rated voltage | DC500V~630V | 120% of the rated voltage | DC1KV~DC3KV | 110% of the rated voltage |
| Operating temperature range | Rated voltage | Test voltage | | | | | | | | | | | | | | | | | |
| COG | Rated voltage $\geq \text{DC1KV}$ | Rated voltage | | | | | | | | | | | | | | | | | |
| | Rated voltage $< \text{DC1KV}$ | 120% of the rated voltage | | | | | | | | | | | | | | | | | |
| X7R | DC100V~250V | 150% of the rated voltage | | | | | | | | | | | | | | | | | |
| | DC500V~630V | 120% of the rated voltage | | | | | | | | | | | | | | | | | |
| | DC1KV~DC3KV | 110% of the rated voltage | | | | | | | | | | | | | | | | | |

| No. | Item | | Specification | | Test Methods and Conditions |
|-----|--|--------------------|---------------|--|---|
| | | | Class I | Class II | |
| 16 | Humidity Load (Application : DC250V item) | Appearance | | No defects which may affect performance | Apply the rated voltage at $40\pm 2^{\circ}\text{C}$ and relative humidity of 90 to 95 for $500+24/-0$ hrs. ·Initial measurement Perform the initial measurement according to Note1 for Class II ·Measurement after test Perform the final measurement according to Note2 |
| | | Capacitance Change | | Within $\pm 15\%$ | |
| | | Dissipation (or Q) | | 7.5% max | |
| | | I.R. | | $C \geq 0.01 \mu\text{F}$: More than $10\text{M}\Omega$, μF $C < 0.01 \mu\text{F}$: More than $1,000\text{M}\Omega$ | |

*Note1. Initial Measurement for Class II

Perform a heat treatment at $150+0, -10^{\circ}\text{C}$ for one hour and then let sit for 24 ± 2 hours at room temperature, then measure

*Note2. Measurement after test

1. Class I

Let sit for 24 ± 2 hours at room temperature, then measurement

2. Class II

Perform a heat treatment at $150+0, -10^{\circ}\text{C}$ for one hour and then let sit for 24 ± 2 hours at room temperature, then measure.

"Following the International standards, the title of each test item is subject to change."

5. Packing

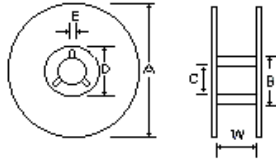
(1) Bulk packing

- ① 1000 pcs per Polybag
- ② 5 Polybags per Inner box
- ③ 10 Inner boxes per Out box

(2) Reel Packing

- ① 8~10 Reels per Inner box
- ② 6 Inner boxes per Out box

(3) Reel Dimensions



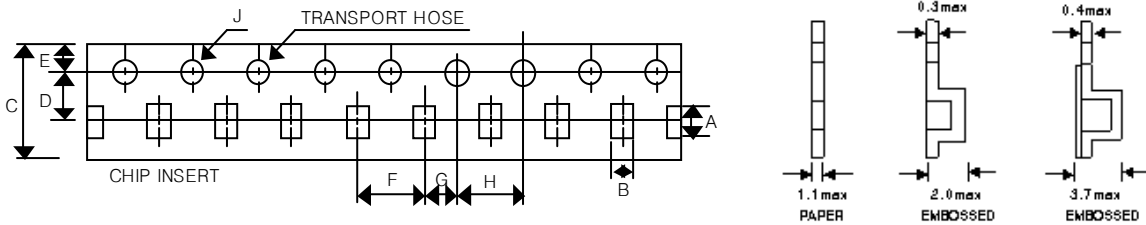
(Unit : mm)

| MARK | SIZE | A | B | C | D | E | W |
|-----------|-----------|-------------------|----------------------|-------------------|-------------------|-------------|--------------|
| 7 " REEL | 0603~3225 | $\Phi 178 \pm 2$ | $\Phi 50 \text{Min}$ | $\Phi 13 \pm 0.5$ | $\Phi 21 \pm 0.8$ | 2 ± 0.5 | 10 ± 1.5 |
| | 4520~4532 | $\Phi 180 +0, -3$ | $\Phi 60 -0, +1$ | $\Phi 13 \pm 0.2$ | $\Phi 57 -0 +1$ | 3 ± 0.2 | 13 ± 0.5 |
| 13 " REEL | 1005~3225 | $\Phi 330 \pm 2$ | $\Phi 70 \text{Min}$ | $\Phi 13 \pm 0.5$ | $\Phi 21 \pm 0.8$ | 2 ± 0.5 | 10 ± 1.5 |

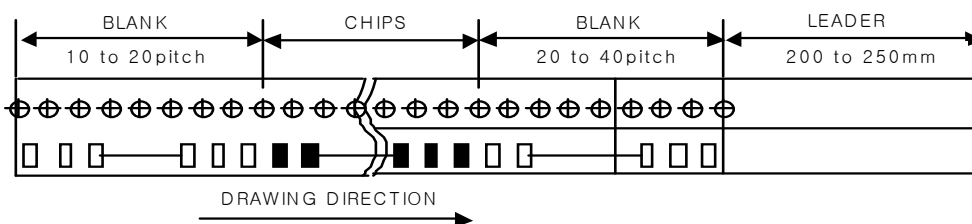
(4) Number of Package

| TYPE | EIA CODE | 7" | 13" |
|--------|----------|---------------|----------------|
| | | Qt/REEL | Qt/REEL |
| CS0603 | CC0201 | 15,000 | |
| CS1005 | CC0402 | 10,000 | 50,000 |
| CS1608 | CC0603 | 4,000 | 15,000 |
| CS2012 | CC0805 | 3,000 ~ 4,000 | 8,000 ~ 15,000 |
| CS3216 | CC1206 | 2,000 ~ 4,000 | 6,000 ~ 10,000 |
| CS3225 | CC1210 | 1,000 ~ 3,000 | 4,000 ~ 10,000 |
| CS4520 | CC1808 | 1,500 ~ 3,000 | - |
| CS4532 | CC1812 | 500 ~ 1,000 | 1,500 ~ 5,000 |

(5) Tape Dimensions



| TYPE | EIA CODE | A | B | C | D | E | F | G | H | J |
|--------|----------|-----------------|-----------------|----------------|----------------|----------------|--------------------------------|---------------|---------------|---------------|
| CS0603 | CC0201 | 0.67 ± 0.05 | 0.37 ± 0.05 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 2.0 ± 0.05 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS1005 | CC0402 | 1.15 ± 0.1 | 0.65 ± 0.1 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 2.0 ± 0.05 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS1608 | CC0603 | 1.9 ± 0.2 | 1.10 ± 0.2 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 4.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS2012 | CC0805 | 2.4 ± 0.2 | 1.65 ± 0.2 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 4.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS3216 | CC1206 | 3.6 ± 0.2 | 2.00 ± 0.2 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 4.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS3225 | CC1210 | 3.6 ± 0.2 | 2.80 ± 0.2 | 8.0 ± 0.3 | 3.5 ± 0.05 | 1.75 ± 0.1 | 4.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS4520 | CC1808 | 4.8 ± 0.2 | 2.3 ± 0.2 | 12.0 ± 0.3 | 5.5 ± 0.1 | 1.75 ± 0.1 | 4.0 ± 0.1 8.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |
| CS4532 | CC1812 | 4.9 ± 0.2 | 3.6 ± 0.2 | 12.0 ± 0.3 | 5.5 ± 0.1 | 1.75 ± 0.1 | 8.0 ± 0.1 | 2.0 ± 0.1 | 4.0 ± 0.1 | 1.5 ± 0.1 |



6. Caution

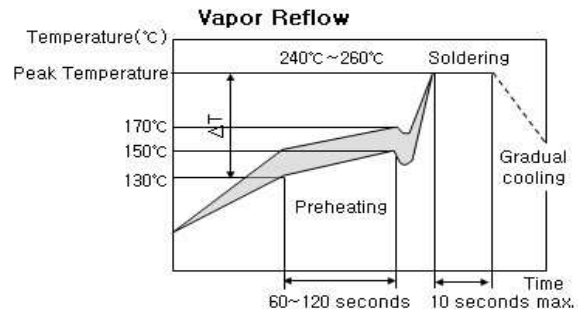
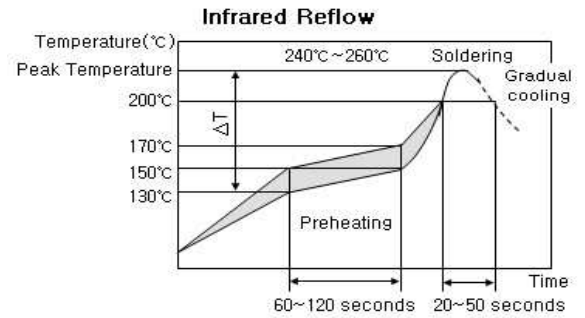
▶ Reflow Soldering

1. The sudden temperature change easily causes mechanical damages to ceramic components. Therefore, the preheating procedures should be required for the soldering of ceramic components.
2. Please refer to the recommended soldering profiles as shown in figures, and keep the temperature difference(ΔT) within the range recommended in Table 1.

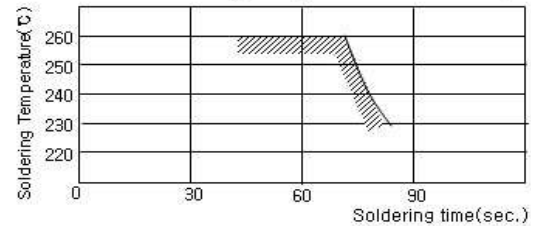
Table 1

| Size code | Temperature Difference |
|------------------------------|-----------------------------------|
| 0603, 1005, 1608, 2012, 3216 | $\Delta T \leq 190^\circ\text{C}$ |
| 3225size and over | $\Delta T \leq 130^\circ\text{C}$ |

[Standard Conditions for Reflow Soldering]



[Allowable Soldering Temperature and Time]



In case of repeated soldering, the accumulated soldering time must be within the range shown above.

▶ Storage Condition

*When Solderability is considered, Capacitor are recommended to be used in 12 months

- (1) Temperature: $25^\circ\text{C} \pm 10^\circ\text{C}$
- (2) Relative Humidity: Below 70% RH

▶ The Regulation of Environmental Pollution Materials.

*Never use materials mentioned below in MLCC products regulated this document.

Pb, Cd, Hg, Cr^{+6} , PBB(Polybromide biphenyl), PBDE(Polybrominated diphenyl ethers), asbestos.

* Note

(1) 'Aging'/'De-aging' Behavior of high dielectric MLCCs

(Typically represented by X7R, Y5V temperature characteristic of which main composition is BaTiO₃)

'Aging' / 'De-aging' Behavior of high dielectric MLCCs Please note that high dielectric type dielectric Ceramic Capacitors have a "normal" 'aging' behavior / characteristic, that is; their capacitance value decreases with time from its value when it was first manufactured. From that date, the capacitance value begins to decrease at a logarithmic rate defined by:

$$C_t = C_{24} (1 - k \log_{10} t)$$

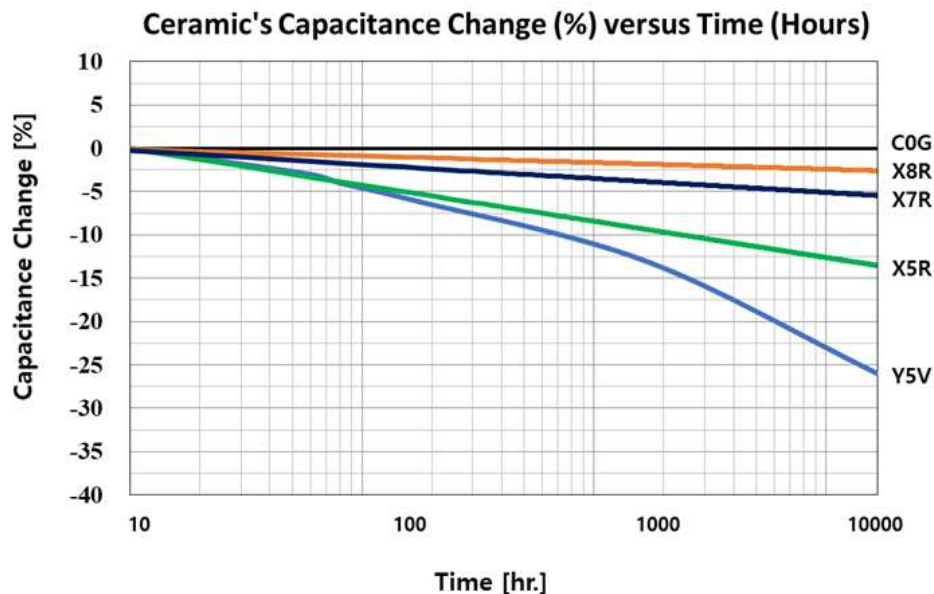
where :

C_t = Capacitance Value, t hours after the start of 'aging'

C_{24} = Capacitance Value, 24 hours after its manufacture

k = aging constant (capacitance decrease per decade-hour)

t = time, in hours, from the start of 'aging'



The capacitance value can be restored (a.k.a. 'de-aged') by exposing the component to elevated temperatures approaching its Curie Temperature (approximately 120°C). This 'deaging' can occur during the component's solder-assembly onto the PCB, during life or temperature cycle testing., or by ' baking ' at 150°C for about 1 hour.

(2) Please contact our sales representatives or product engineers before using the products in this catalog for the applications listed below, which require especially high reliability for the prevention of defects which might directly damage a third party's life, body or property, or when one of our products is intended for use in applications other than those specified in this catalog.

- ① Aircraft equipment ② Aerospace equipment ③ Undersea equipment ④ Power plant equipment
- ⑤ Medical equipment ⑥ Transportation equipment (vehicles, trains, ships, etc.)
- ⑦ Traffic signal equipment ⑧ Disaster prevention / crime prevention equipment
- ⑨ Industrial equipment (Conveyors, Robot equipment, etc) ⑩ Led equipment
- ⑪ Application of similar complexity and/or reliability requirements to the applications listed above

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [Multilayer Ceramic Capacitors MLCC - SMD/SMT](#) category:

Click to view products by [Samwha](#) manufacturer:

Other Similar products are found below :

[M39014/02-1218V](#) [M39014/02-1225V](#) [M39014/22-0631](#) [D55342E07B523DR-T/R](#) [NIN-FB391JTRF](#) [NIN-FC2R7JTRF](#)
[NMC0402NPO220J50TRPF](#) [NMC0402X5R105K6.3TRPF](#) [NMC0402X5R224K6.3TRPF](#) [NMC0402X7R103J25TRPF](#)
[NMC0402X7R153K16TRPF](#) [NMC0603NPO101F50TRPF](#) [NMC0603NPO1R8C50TRPF](#) [NMC0603NPO201J50TRPF](#)
[NMC0603X5R475M6.3TRPF](#) [NMC0805NPO270J50TRPF](#) [NMC0805NPO681F50TRPF](#) [NMC0805NPO820J50TRPF](#)
[NMC0805X7R224K16TRPLPF](#) [NMC0805X7R224K25TRPF](#) [NMC1206X7R102K50TRPF](#) [NMC1206X7R475K10TRPLPF](#) [NMC-](#)
[Q0402NPO8R2D200TRPF](#) [C1206C101J1GAC](#) [C1608C0G2A221J](#) [C1608X7R1E334K](#) [C2012C0G2A472J](#) [2220J2K00562KXT](#)
[1812J2K00332KXT](#) [CDR04BX104AKSR](#) [CDR31BX103AKWR](#) [CDR33BX104AKUR](#) [CDR33BX683AKUS](#) [CGA2B2C0G1H010C](#)
[CGA2B2C0G1H040C](#) [CGA2B2C0G1H050C](#) [CGA2B2C0G1H060D](#) [CGA2B2C0G1H070D](#) [CGA2B2C0G1H120J](#) [CGA2B2C0G1H151J](#)
[CGA2B2C0G1H1R5C](#) [CGA2B2C0G1H2R2C](#) [CGA2B2C0G1H390J](#) [CGA2B2C0G1H391J](#) [CGA2B2C0G1H3R3C](#) [CGA2B2C0G1H680J](#)
[CGA2B2C0G1H6R8D](#) [CGA2B2C0G1H820J](#) [CGA2B2X8R1H152K](#) [CGA2B2X8R1H221K](#)